MicroCapacitance (MC) SA SIDACtor® Device







These DO-214AA SAMC SIDACtor devices are intended for applications sensitive to load values. Typically, high speed connections, such as Ethernet, xDSL, and T1/E1, require a lower capacitance. Co values for the MicroCapacitance device are 40% lower than a standard SA part.

This SAMC SIDACtor series enables equipment to comply with various regulatory requirements including GR 1089, ITU K.20, K.21, and K.45, IEC 60950, UL 60950, and TIA-968-A (formerly known as FCC Part 68).

Electrical Parameters

Part Number *	V _{DRM} Volts	V _S Volts	V _T Volts	I _{DRM} μAmps	I _S mAmps	I _T Amps	I _H mAmps
P0080SAMCL	6	25	4	5	800	2.2	50
P0220SAMCL	15	32	4	5	800	2.2	50
P0300SAMCL	25	40	4	5	800	2.2	50

^{* &}quot;L" in part number indicates RoHS compliance. For non-RoHS compliant device, delete "L" from part number. For surge ratings, see table below.

General Notes:

- All measurements are made at an ambient temperature of 25 °C. IPP applies to -40 °C through +85 °C temperature range.
- IPP is a repetitive surge rating and is guaranteed for the life of the product.
- · Listed SIDACtor devices are bi-directional. All electrical parameters and surge ratings apply to forward and reverse polarities.
- V_{DRM} is measured at I_{DRM}.
- V_S is measured at 100 V/µs.
- Special voltage (V_S and V_{DRM}) and holding current (I_H) requirements are available upon request.

Surge Ratings in Amps

	I _{PP}										
Series	0.2x310 * 0.5x700 **	2x10 * 2x10 **	8x20 * 1.2x50 **		10x560 * 10x560 **			10x1000 * 10x1000 **		I _{TSM} 50 / 60 Hz	di/dt
	Amps	Amps	Amps	Amps	Amps	Amps	Amps	Amps	Amps	Amps	Amps/µs
Α	20	150	150	90	50	75	75	45	75	20	500

* Current waveform in μs
** Voltage waveform in μs



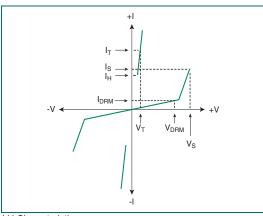
Thermal Considerations

Package	Symbol	Parameter	Value	Unit
DO-214AA	DO-214AA T _J Operating Junction Temperature Range			
	T _S	Storage Temperature Range	-65 to +150	°C
	$R_{\theta JA}$	Thermal Resistance: Junction to Ambient	90	°C/W

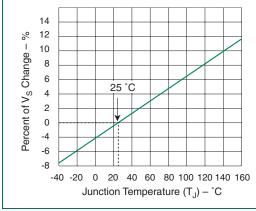
Capacitance Values

	pF		
Part Number	MIN	MAX	
P0080SAMCL	25	55	
P0220SAMCL	25	50	
P0300SAMCL	15	35	

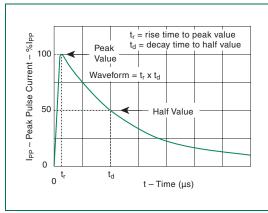
Note: Off-state capacitance (C_O) is measured at 1 MHz with a 2 V bias.



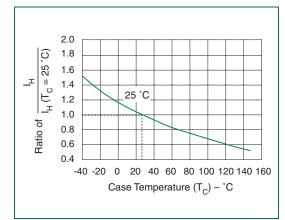
V-I Characteristics



Normalized $V_{\mbox{\scriptsize S}}$ Change versus Junction Temperature



t_r x t_d Pulse Waveform



Normalized DC Holding Current versus Case Temperature